HILD SEMICONDUCTOR		84	DE 346967	4 0027605
3469674 FAIRCHILD S	EMICONDUCT	OR	84D 27605	D
FAIRCHILD			20/2N5321 22/2N5323	T-33-07
A Schlumberger Company			t NPN-PNP Sil	
• V _{CE(set)} 0.7 V			PACKAGE	
• h _{FE} 40-250 @ V _{CE} = 4.0 V, I _C	= 0.5 A		2N5320	TO-39
 Complements 2N5320, NPN 2N5321, NPN (2N5322, PNP) 	(2N5322, PNP);		2N5321 2N5322	TO-39
			2N5322 2N5323	TO-39 TO-39
ABSOLUTE MAXIMUM RATINGS	(Note 1)			10.00
Temperatures				
Storage Temperature	-65°C to 200°C			
Operating Junction Temperature	200° C			
Power Dissipation (Notes 2 & 3) Total Dissipation at				
25° C Case Temperature	10 W			
Linear Derating Factor	0.057W/°C			
Voltages & Currents	5320	5321		
VCEO Collector to Emitter Voltage	75 V	50 V		
VCBO Collector to Base Voltage	100 V	75 V		
VEBO Emitter to Base Voltage	7.0 V	5.0 V		
lc Collector Current	2.0 A	2.0 A		
IB Base Current	1.0 A	1.0 A		
Voltages & Currents	5322	5322		
VCEO Collector to Emitter Voltage	75 V	-50 V		
VCBO Collector to Base Voltage	-100 V	~75 V		
VEBO Emitter to Base Voltage	-7.0 V	–5.0 V		
lc Collector Current	2.0 A	2.0 A		
IB Base Current	1.0 A	1.0 A		

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL (CHARACTERISTIC	53 MIN	20 MAX	53 MIN	21 MAX	UNITS	TEST CONDITIONS
I _{EBO} E	Emitter Cutoff Current		0.1		0.1	mA mA	$V_{EB} = 7.0 V$ $V_{EB} = 5.0 V$

NOTES:

1. 2.

3.

4.

JTES: These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired. Pulse conditions: length = 300 μs; duty cycle ≤ 10% Pulse Rep. Frequency = 1 kHz, pulse width = 20 μs. These ratings give a maximum junction temperature of 200° C and junction-to-case thermal resistance of 0.2° C/W (derating factor of 0.057 W/° C. Emitter diode is reversed biased. For product family characteristic curves, refer to Curve Set T314 (2N5320 and 2N5321) and Curve Set T414 (2N5322 and 2N5323).

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3469674 FAIRCHILD SEMICONDUCTOR

84D 27606 D 7. 33-07

2N5320/2N5321 2N5322/2N5323

T. 33-17

		53	20	53	321		
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
ICEX	Collector Cutoff Current (Note 3)		5.0			mA	$V_{CE} = 70 \text{ V}, V_{BE} = 1.5 \text{ V},$ T _C = 150°C
	(14018-5)				5.0	mA	$V_{CE} = 45 \text{ V}, V_{BE} = 1.5 \text{ V},$ T _C = 150°C
			0.1		0.1	mA mA	$V_{CE} = 100 \text{ V}, V_{BE} = 1.5 \text{ V}$ $V_{CE} = 75 \text{ V}, V_{BE} = 1.5 \text{ V}$
hfe	DC Current Gain (Note 2)	10 30	130	40	250		$ I_{C} = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V} \\ I_{C} = 0.5 \text{ A}, V_{CE} = 4.0 \text{ V} $
V _{CEO(sus)}	Collector to Emitter Sustaining Voltage (Note 2)	75		50		V	$I_{c} = 100 \text{ mA}, I_{B} = 0$
V _{CE(sat)}	Collector to Emitter Saturation Voltage (Note 2)		0.5		0.8	V	$I_{\rm C} = 500 \text{ mA}, I_{\rm B} = 50 \text{ mA}$
VBE(ON)	Base to Emitter "On" Voltage (Note 2)		1.1		1.4	V	$I_{\rm C} = 500 \text{ mA}, V_{\rm CE} = 4.0 \text{ V}$
h _{te}	Small Signal Current Gain	5.0		5.0			$I_{C} = 50 \text{ mA}, V_{CE} = 4.0 \text{ V}, f = 10 \text{ MHz}$
ton	Turn On Time (Note 3)		80		80	ns	$I_{C} = 500 \text{ mA}, I_{B1} = 50 \text{ mA}$
toff	Turn Off Time (Note 3)		800		800	ns	$I_{C} = 500 \text{ mA}, I_{B1} = 50 \text{ mA}$ $I_{B2} = -50 \text{ mA}$

		53	22	53	23		
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
IEBO	Emitter Cutoff Current		0.1		0.1	mA mA	$V_{EB} = -7.0 V$ $V_{EB} = -5.0 V$
ICEX	Collector Cutoff Current		5.0			mA	$V_{CE} = -70 \text{ V}, V_{BE} = -1.5 \text{ V},$ $T_{C} = 150^{\circ}\text{C}$
					5.0	mA	$V_{CE} = -45 \text{ V}, V_{BE} = -1.5 \text{ V},$ $T_{C} = 150^{\circ}\text{C}$
			0.1		0.1	mA mA	$V_{CE} = -100 \text{ V}, V_{BE} = -1.5 \text{ V}$ $V_{CE} = -75 \text{ V}, V_{BE} = -1.5 \text{ V}$
hfe	DC Current Gain	10 30	130	40	250		$ I_{c} = 1.0 \text{ A}, V_{CE} = -2.0 \text{ V} \\ I_{c} = 500 \text{ mA}, V_{CE} = -4.0 \text{ V} $
V _{CEO(sus)}	Collector to Emitter Sustaining Voltage (Note 2)	-75		-50		V	$I_{\rm C} = -100 \text{ mA}, I_{\rm B} = 0$
V _{CE(sat)}	Collector to Emitter Saturation Voltage (Note 2)		-0.7		-1.20	V	$I_{\rm C} = 50 \text{ mA}, I_{\rm B} = 50 \text{ mA}$
VBE(ON)	Base to Emitter "On" Voltage (Note 2)		-1.1		-1.4	V	$I_{c} = 500 \text{ mA}, V_{ce} = -4.0 \text{ V}$
hte	Small Signal Current Gain	5.0		5.0			$I_c = 50 \text{ mA}, V_{cE} = 4.0 \text{ V}, I = 10 \text{ MHz}$
ton	Turn On Time (Note 3)		100		100	ns	$I_c = 500 \text{ mA}, I_{B1} = -50 \text{ mA}$
toff	Turn Off Time (Note 3)		1000		1000	ns	$I_{c} = 500 \text{ mA}, I_{B1} = -50 \text{ mA}$ $I_{B2} = 50 \text{ mA}$

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84D 27607 3469674 FAIRCHILD SEMICONDUCTOR

D T-33-05

TO-5

TO-5

2N5336/2N5338

AIRCHILD

A Schlumberger Company

:

6 Watt NPN Silicon Power

PACKAGE

2N5336

2N5338

• P _D 6.0 W @ T _C = 25° C		Pn		6.0	W	@	Tc	=	25°	С	
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- LVCEO ... 80 V and 100 V (Min)
- V_{CE(sat)} ... 1.2 V (Max) @ 5.0 A

ABSOLUTE MAXIMUM RATINGS (Note 1)

Temperatures Storage Temperature Operating Junction Temperature	-65° C to 200° C 200° C
Power Dissipation Total Dissipation at 25° C Case Temperature	6.0 W
Voltages & Currents	5336

Volta	ges & Currents	5336	5338
V	Collector to Emitter Voltage	80 V	i 100 V
VCEO	Collector to Base Voltage	80 V	100 V
VCBO	Emitter to Base Voltage	6.0 V	6.0 V
lc	Collector Current	5.0 A	5.0 A
le le	Base Current	1.0 A	1.0 A

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 4)

							1
	CHARACTERISTIC	53 MIN	36 MAX	53 MIN	38 MAX	UNITS	TEST CONDITIONS
SYMBOL		+	100		100	μA	$V_{EB} = 6.0 \text{ V}, 1_{C} = 0$
I _{EBO}	Emitter Cutoff Current						$V_{CE} = 80 \text{ V}, I_E = 0$
Ісво	Collector Cutoff Current		10		10	μΑ μΑ	$V_{CE} = 100 \text{ V}, I_E = 0$
ICEX	Collector Cutoff Current		10 1.0		10 1.0	μA mA μA mA	$ \begin{array}{l} V_{CE} = 75 \ V, \ V_{BE} = 1.5 \ V \\ V_{CE} = 75 \ V, \ V_{EB} = 1.5 \ V, \\ T_{c} = 150^{\circ} C \\ V_{CE} = 90 \ V, \ V_{BE} = 1.5 \ V \\ V_{CE} = 90 \ V, \ V_{BE} = 1.5 \ V, \\ T_{c} = 150^{\circ} C \end{array} $
hfe	DC Current Gain (Note 2)	30 30 20	120	30 30 20	120		

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.

Constructions, rengin - 000 µs, outy cycle µ 270.
 These ratings give a maximum junction temperature of 2000C and junction-to-case thermal resistance of 33.30C/W (linear derating factor of 34 mW/0C.
 For product family characteristic curves, refer to Curve Set T316.



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3469674 FAIRCHILD SEMICONDUCTOR

84D 27608 D

2N5336/2N5338 T-33-05

	CHARACTERISTICS (25° C Ami	5336			338		TEST CONDITIONS
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	
V _{CEO(sus})	Collector to Emitter Sustaining Voltage (Note 2)	80		100		V	$I_{c} = 50 \text{ mA}, I_{B} = 0$
V _{CE(sat)}	Collector to Emitter Saturation Voltage (Pulsed) (Note 2)		0.7		0.7 1.2	V V	$I_{C} = 2.0 \text{ A}, I_{B} = 200 \text{ mA}$ $I_{C} = 5.0 \text{ A}, I_{B} = 500 \text{ mA}$
VBE(sat)	Base Saturation Voltage (Pulsed) (Note 2)		1.2 1.8		1.2 1.8	V V	$I_{C} = 2.0 \text{ A}, I_{B} = 200 \text{ mA}$ $I_{C} = 5.0 \text{ A}, I_{B} = 500 \text{ mA}$
t _a	Turn On Delay Time		100		100	ns	$I_{C} = 2.0 \text{ A}, V_{CC} = 4.0 \text{ V}, I_{B1} = 200 \text{ mA}$
t _r	Turn On Rise Time	<u> </u> -	100		100	ns	$I_{C} = 2.0 \text{ A}, V_{CC} = 40 \text{ V},$ $I_{B1} = 200 \text{ mA}$
ts	Turn Off Storage Time		2.0		2.0	μS	$I_{C} = 2.0 \text{ A}, V_{CC} = 40 \text{ V},$ $I_{B1} = I_{B2} = 200 \text{ mA}$
t _r	Turn Off Fall Time		200		200	ns	$I_{C} = 2.0 \text{ A}, V_{CC} = 40 \text{ V},$ $I_{B1} = I_{B2} = 200 \text{ mA}$

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RCHILD SEMICONDUCTOR		8 4	DE 3469674	0052877 8
3469674 FAIRCHILD SE	MICONDUC	TOR	84D 2761	1 D
FAIRCHILD		2N5	415/2N5416	T-33-17
A Schlumberger Company		PNP	Silicon Power T	ransistor
10 W Dissipation at 25°C Case			PACKAGE	
 I A (Max) Continuous Collector Cul Up to 350 V V_{CBO} Rating (2N5416) Complements 2N3439, 2N3440 	rrent		2N5415 2N5416	ТО-39 ТО-39
ABSOLUTE MAXIMUM RATINGS (Not	e 1)			~
Temperatures				
Storage Temperature -65° Operating Junction Temperature	C to 200° C 200° C			
Power Dissipation (Notes 2 & 3) Total Dissipation at				
25° C Case Temperature	10 W			
Voltages & Currents (Note 4)	5415	5416		
V _{CEO} Collector to Emitter Voltage	-200 V	–300 V		
•		950 V		
V _{CBO} Collector to Base Voltage	200 V	-350 V		
	200 V 4.0 V 1.0 A	-350 V -4.0 V 1.0 A		

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ELECTRICAL CHARACTERISTICS	(25° C Ambient	Temperature unless	otherwise noted) (N	Note 6)
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		54	15	54	16		
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
IEBO	Emitter Cutoff Current		20		20	μΑ μΑ	
Ісво	Collector Cutoff Current		50		50	μΑ μΑ	$V_{CB} = -175 \text{ V}, I_E = 0$ $V_{CB} = -280 \text{ V}, I_E = 0$
ICEV	Collector Cutoff Current		50		50	μΑ μΑ	
ICEO	Collector Cutoff Current		50		50	μΑ μΑ	$V_{CE} = -150 \text{ V}, I_B = 0$ $V_{CE} = -250 \text{ V}, I_B = 0$
h _{FE}	DC Current Gain (Note 5)	30	150	30	120		$I_{c} = 50 \text{ mA}, V_{cE} = -10 \text{ V}$

NOTES:
1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 200° C and junction-to-case thermal resistance of 0.2° C/W (derating factor of 0.057 mW/° C).
4. Rating refers to a high current point where collector to emitter voltage is lowest.
5. Pulse conditions: length = 300 µs; duty cycle = 2%.
6. For product family characteristic curves, refer to Curve Set T443.

DE 3469674 0027612 8 84 FAIRCHILD SEMICONDUCTOR D 84D 27612 3469674 FAIRCHILD SEMICONDUCTOR 2N5415/2N5416 T-33-17 ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6) 5415 5416 TEST CONDITIONS MIN MAX UNITS MIN MAX CHARACTERISTIC SYMBOL $I_{C} = 50 \text{ mA}, I_{B} = 0$ ۷ Collector to Emitter Sustaining -200 --300 V_{CEO(sus}) Voltage (Note 5) $I_c = 50 \text{ mA}, R_{BE} = 50 \Omega$ v Collector to Emitter Sustaining -350 VCER(sus) Voltage (Note 5) $I_{c} = 50 \text{ mA}, I_{B} = 5.0 \text{ mA}$ ۷ Collector to Emitter Saturation -2.0 -2.5 VCE(sat) Voltage (Note 5) $I_{\text{C}}=50\text{ mA},\,V_{\text{CE}}=-10\text{ V}$ v Base to Emitter "On" Voltage -1.5 -1.5 VBE(ON) $V_{CB} = -10 V, I_E = 0$ 15 15 pF **Output Capacitance** Cob f = 1.0 MHz $V_{EB} = -5.0 \text{ V}, I_{C} = 0$ 75 pF 75 Input Capacitance $C_{\iota b}$ f = 1.0 MHz

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100

Magnitude of Common Emitter

Small Signal Current Gain

Real Part of Common Emitter

Second Breakdown Collector

Small Signal Current Gain

Small Signal Short-Circuit Impedance

Current

h_{fe}

h_{fe}

R_e(h_{ie})

ls/b

3-332

3.0

25

100

300

Ω

mΑ

300

 $I_c = 10 \text{ mA}, V_{CE} = -10 \text{ V},$

 $I_c = 5.0 \text{ mA}, V_{CE} = -10 \text{ V},$

 $I_c = 5.0 \text{ mA}, V_{CE} = -10 \text{ V},$

 $V_{CE} = -100 \text{ V}, t = 1.0 \text{ s}$

f = 5.0 MHz

f = 1.0 kHz

f = 1.0 MHz

(non repetitive)

469674 FAIRCHILD SI	EMICONDUCT	2N55	84D 27613 50/FTSO55	50 T-29-2
			51/MPS555	1
A Schlumberger Company			D5551	
			Small Signal Hi	
		Genera	al Purpose Am	plifiers
• V _{CEO} 160 V (Min) (MPS/FTS	05551)		PACKAGE	
 V_{CEO} 160 V (Mill) (MFS/F13 h_{FE} 80-250 @ 10 mA (MPS/I 			2N5550	TO-92
• V _{CE(sat)} 0.2 V (max) @ 50 mA	(MPS/FTSO5551)		2N5551	TO-92
• Complements 2N5400, 2N54	401		MPS5551	TO-92
ABSOLUTE MAXIMUM RATINGS	(Note 1)		FTSO5550 FTSO5551	TO-236AA/AB TO-236AA/AB
Temperatures				
Storage Temperature	-55° C to 150° C			
Operating Junction Temperature	150° C			
Power Dissipation (Notes 2 & 3)				
Total Dissipation at	2N	FTSO		
25° C Ambient Temperature	0.625 W	0.350 W*		
25° C Case Temperature	1.0 W			
Voltages & Currents	5550	5551		
V _{CEO} Collector to Emitter Voltage		160 V		
(Note 4)		180 V		
V _{CBO} Collector to Base Voltage V _{EBO} Emitter to Base Voltage	160 V 6.0 V	6.0 V		

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

			50		51		
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
BVCEO	Collector to Emitter Breakdown Voltage	140		160		V	$I_{\rm C} = 1.0 \text{ mA}, I_{\rm B} = 0$
ВV _{сво}	Collector to Base Breakdown Voltage	160		180		v	$I_{c} = 100 \ \mu A, \ I_{E} = 0$
ВV _{ЕВО}	Emitter to Base Breakdown Voltage	6.0		6.0		V	$I_{\rm E} = 10 \ \mu {\rm A}, \ I_{\rm C} = 0$
IEBO	Emitter Cutoff Current		50		50	nA	$V_{EB} = 4.0 \text{ V}, \text{ I}_{C} = 0$
Ісво	Collector Cutoff Current		100 100		50	nA nA μA	
					50	μA	$V_{CB} = 120 \text{ V}, I_E = 0, T_A = 100^{\circ} \text{ C}$

NOTES:

1. These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.

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2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

3. These ratings give a maximum junction temperature of 150° C and (TO-92) junction-to-case thermal resistance of 125° C/W (derating factor of 8 0 mW/° C); junction-to-ambient thermal resistance of 200° C/W (derating factor of 5.0 mW/° C); (TO-236) junction-to-ambient thermal resistance of 357° C/W (derating factor of 2.8 mW/° C).

Rating refers to a high current point where collector to emitter voltage is lowest. Pulse conditions: length = 300 µs; duty cycle = 1%. For product family characteristic curves, refer to Curve Set T147. Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm. 4.

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3469674 FAIRCHILD SEMICONDUCTOR

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84D 27614 D

2N5550/FTSO5550 2N5551/MPS5551 FTSO5551

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T-29.23

		5550 MIN MAX		55 MIN	51 MAX	UNITS	TEST CONDITIONS
SYMBOL hfe	CHARACTERISTIC DC Pulse Current Gain (Note 5)		250	80 80 30	250		
VCE(sat)	Collector to Emitter Saturation Voltage (Note 5)		0.15 0.25		0.15 0.25	V V	$I_{c} = 10 \text{ mA}, I_{B} = 1.0 \text{ mA}$ $I_{c} = 50 \text{ mA}, I_{B} = 5.0 \text{ mA}$
V _{BE(sat)}	Base to Emitter Saturation Voltage (Note 5)		1.0 1.2		1.0 1.0	V V	$I_{C} = 10 \text{ mA}, I_{B} = 1.0 \text{ mA}$ $I_{C} = 50 \text{ mA}, I_{B} = 5.0 \text{ mA}$
Cop	Output Capacitance		6.0		6.0	pF	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1.0 \text{ MH}$
Cıb	Input Capacitance (2N/FTSO5550) (MPS/FTSO5551) (2N5551)		30		30 20	pF pF pF	
h _{fe}	Small Signal Current Gain	50	200	50	200		$I_{c} = 1.0 \text{ mA}, V_{cE} = -10 \text{ V}, I = 1.0 \text{ kHz}$
fī	Current Gain Bandwidth Product	100	300	100	300	MHz	$I_{c} = 10 \text{ mA}, V_{cE} = 10 \text{ V}, $ f = 100 MHz
NF	Noise Figure		10		8.0	dB	$ I_{c} = 250 \ \mu A, \ V_{CE} = 5.0 \ V, \\ f = 10 \ Hz \ to \ 15.7 \ kHz, \\ R_{s} = 1.0 \ k\Omega $

RCHILD SEMICONDU		84 DE 3	169674 00276						
69674 FAIRCHILD S		84D 27615	D						
	2N56	679/2N568	T-33-0						
FAIRCHILD			2N5681/2N5682 T.33-17						
A Schlumberger Company									
•			np 10 Watt N						
		Comp	lementary Po	wer					
 f₁ 30 MHz @ l_c = 100 n 	nA		PACKAGE						
• V _{CE(sat)} 0.6 V @ I _C = 0.2			2N5679	TO-39					
Complements 2N5679,	PNP (2N5681, NPN);		2N5680	TO-39					
2N5680, PNP (2N5682, NP			2N5681 2N5682	TO-39 TO-39					
			210002	10-38					
ABSOLUTE MAXIMUM RATI	NGS (Note 1)								
Temperatures									
Storage Temperature	-65° C to 200° C ture 200° C								
Operating Junction Temperat	ture 200°C								
Power Dissipation (Notes 2 &	3)								
Continuous Dissipation at									
25° C Ambient Temperature	1.0 W								
Continuous Dissipation at									
25° C Case Temperature	10 W								
Voltages & Currents (Note 4)		5680							
V _{CEO} Collector to Emitter Vo		-120 V							
VCBO Collector to Base Volta		-120 V							
VEBO Emitter to Base Voltage		-4.0 V							
Ic Collector Current	1.0 A	1.0 A							
IB Base Current	0.5 A	0.5 A							
Voltages & Currents (Note 4)		5682							
V _{CEO} Collector to Emitter Vo		120 V							
V _{CBO} Collector to Base Volta		120 V							
VEBO Emitter to Base Voltag		4.0 V							
Ic Collector Current	1.0 A	1.0 A							
IB Base Current	0.5 A	0.5 A							

ELECTRICAL CHARACTERISTICS (25°C Ambient Temperature unless otherwise noted) (Note 6)

		56	679		680		
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
I _{EBO}	Emitter Cutoff Current		1.0		1.0	μA	$V_{EB} = -4.0 \text{ V}, I_{C} = 0$
Ісво	Collector Cutoff Current		1.0		1.0	μΑ μΑ	$V_{CB} = -100 \text{ V}, I_E = 0$ $V_{CB} = -120 \text{ V}, I_E = 0$

NOTES:

NOTES:
 These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
 These are steady state limits The factory should be consulted on applications involving pulsed or low duty cycle operations.
 These ratings give a maximum junction temperature of 200° C and junction-to-case thermal resistance of 0.2° C/W (derating factor of 0.057 mW/° C); junction-to-ambient thermal resistance of 0.02° C/W (derating factor of 0.057 mW/° C).
 Rating refers to a high current point where collector to emitter voltage is lowest.
 Pulse conditions: length = 300 µs; duty cycle = 2%.
 For product length: above prior to fact the Current case that a Current case the current ca

For product family characteristic curves, refer to Curve Set T415 (2N5679 and 2N5680) and Curve Set T315 (2N5681 and 2N5782) 6.

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3469674 FAIRCHILD SEMICONDUCTOR

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2N5679/2N5680 2N5681/2N5682

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T. 33-17

	5679 5680		80				
SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
I _{CEO}	Collector Cutoff Current		10		10	μΑ μΑ	$V_{CB} = -70 V, I_B = 0$ $V_{CB} = -80 V, I_B = 0$
ICEX	Collector Reverse Current (Note 3)		1.0		1.0	mA mA	
			1.0		1.0	μΑ μΑ	$V_{CE} = -100 \text{ V}, V_{BE} = -1.5 \text{ V}$ $V_{CE} = -120 \text{ V}, V_{BE} = -1.5 \text{ V}$
h _{FE}	DC Current Gain (Note 5)	5.0 40	150	5.0 40	150		$I_c = 1.0 \text{ A}, V_{CE} = -2.0 \text{ V}$ $I_c = 250 \text{ mA}, V_{CE} = -2.0 \text{ V}$
V _{CEO(sus)}	Collector to Emitter Sustaining Voltage (Note 5)	-100		-120		V	$I_{\rm C} = 10 \text{ mA}, I_{\rm B} = 0$
V _{CE(sat)}	Collector to Emitter Saturation Voltage (Note 5)		2.0 1.0 0.6		-2.0 -1.0 -0.6	V V V	$ I_{C} = 1.0 \text{ mA}, I_{B} = 200 \text{ mA} \\ I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} = 250 \text{ mA}, I_{B} = 25 \text{ mA} $
VBE(ON)	Base to Emitter "On" Voltage (Note 5)		-1.0		-1.0	V	$I_{c} = 250 \text{ mA}, V_{ce} = -2.0 \text{ V}$
Сов	Common Base Output Capacitance		50		50	pF	$V_{CB} = -20 \text{ mA}, I_E = 0$ f = 1.0 MHz
h₁₀	High Frequency Current Gain	3.0		3.0			$I_c = 100 \text{ mA}, V_{CE} = -10 \text{ V}, I_c = 10 \text{ MHz}$
h _{fe}	Small Signal Current Gain	40		40			$I_c = 200 \text{ mA}, V_{ce} = -1.5 \text{ V}, f = 1.0 \text{ kHz}$

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

3469674 FAIRCHILD SEMICONDUCTOR

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SYMBOL	CHARACTERISTIC	MIN	MAX	MIN	MAX	UNITS	TEST CONDITIONS
I _{EBO}	Emitter Cutoff Current		1.0		1.0	μA	$V_{EB} = 4.0 V, I_{C} = 0$
Ісво	Collector Cutoff Current		1.0		1.0	μA μA	$V_{CB} = 100 \text{ V}, I_E = 0$ $V_{CB} = 120 \text{ V}, I_E = 0$
ICEO	Collector Cutoff Current		10		10	μA μA	
ICEX	Collector Cutoff Current		1.0			mA	$V_{CE} = 100 \text{ V}, V_{BE} = 1.5 \text{ V}, T_{C} = 150^{\circ}\text{C}$
					1.0	mA	$V_{CE} = 120 \text{ V}, V_{BE} = -1.5 \text{ V}$ $T_{C} = 150^{\circ}\text{C}$
			1.0		1.0	μΑ μΑ	$V_{CE} = -100 \text{ V}, V_{BE} = 1.5 \text{ V}$ $V_{CE} = -120 \text{ V}, V_{BE} = 1.5 \text{ V}$
h _{FE}	DC Current Gain (Note 5)	5.0 40	150	5.0 40	150		$ I_{c} = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V} \\ I_{c} = 250 \text{ mA}, V_{CE} = 2.0 \text{ V} $
V _{CEO(sus)}	Collector to Emitter Sustaining Voltage (Note 5)	100		120		V	$I_{c} = 10 \text{ mA}, I_{B} = 0$
V _{CE(sat)}	Collector to Emitter Saturation Voltage (Note 5)		2.0 1.0		2.0 1.0	V V	$I_{C} = 1.0 \text{ mA}, I_{B} = 200 \text{ mA}$ $I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA}$
			0.6		0.6	V	$I_{C} = 250 \text{ mA}, I_{B} = 25 \text{ mA}$
VBE(ON)	Base to Emitter "On" Voltage (Note 2)		1.0		1.0	V	$I_{c} = 250 \text{ mA}, V_{CE} = 2.0 \text{ V}$
Сор	Output Capacitance		50		50	pF	$V_{CB} = 20 \text{ mA}, I_E = 0$ f = 1.0 MHz
h _{fe}	High Frequency Current Gain	3.0		3.0			$I_{c} = 100 \text{ mA}, V_{CE} = 10 \text{ V}, f = 10 \text{ MHz}$
h _{te}	Small Signal Current Gain	40		40			$I_c = 200 \text{ mA}, V_{ce} = 1.5 \text{ V}, f = 1.0 \text{ kHz}$

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